Sheet <u>1</u> of U.S. DEPARTMENT OF COMMERCE ATTY, DOCKET NO. SERIAL NO. FORM PTO-1449 PATENT AND TRADEMARK OFFICE ASA-1063 10/073,886 (REV. 7-80) APPLICANT LIST OF DOCUMENTS CITED BY APPLICANT T. Uemura et ak (Use several sheets if necessary) FILING DATE **GROUP** 2002 February 14, 2878 **U.S. PATENT DOCUMENTS** FILING DATE * EXAMINER DOCUMENT DATE NAME CLASS **SUBCLASS** INITIAL (If Appropriate 11/26/74 3,851,175 Dahlin et al 06 AB AC AD ΑE AF AG 28 AΗ ΑI ΑJ AK FOREIGN PATENT DOCUMENTS TRANSLATIO DOCUMENT DATE COUNTRY CLASS SUBCLASS YES NO 5/18/2000 (with English abstract) 00/28303 WO 96 AL 8/29/2001 EP 1-128178 ΑM 00 0-295486 12/21/88 ΕP 00 0-453797 10/30/91 **O**G 2000-1/3/2001 JP (with English abstract) **OG** 259885 OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, etc.) AR AS ΑT

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